

 Report No.: 18220WC30191301
 FCC ID: 2ACE5-IH2125
 Page 1 of 11

FCC Test Report

Applicant : TELEPHONE EST (HK) CO., LTD

		Room709, 7F, FuLi tianhe commercial	X
Address	Aupor	building, Linhe, East Road and tianhe district	,
		Guangzhou, China	10,

Product Name : 15W Wireless Charging Pad

Report Date

Sept. 22, 2023



Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 2 of 11

Contents

1. General Information	Ann	theotek	Anbo		5
1.1. Client Information	Anbo		photo		5
1.2. Description of Device (EUT)	polore	Pur May		Anbur	5
1.3. Auxiliary Equipment Used Durir	ng Test	ek Anbo		rek pabol	6
1.4. Test Equipment List		otek polo	No. No.		6
1.5. Measurement Uncertainty	pore An		hoten Al	10 ⁻⁰	6
1.6. Description of Test Facility		Ano			6
1.7. Disclaimer	totek	Aupor			7
2. Measurement and Result	Man Mark		Anb		8
2.1. Requirements	Ante	Mator Mater	Aupor		8
2.2. Test Setup	ek pupor		e ^k	en Mun	9
2.3. Test Procedure		oter Anu		pot ^{ek}	9
2.4. Test Result		14. Mator	60. Pr.		9
APPENDIX I TEST SETUP PHOTOG	RAPH	and the second s	popole	Anv	11
APPENDIX II EXTERNAL PHOTOGR	APH	Anu		Anbo	11
APPENDIX III INTERNAL PHOTOGR	APH	Anbo.	witch.	Hobote.	

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 3 of 11

TEST REPORT

Applicant	e¥ :	TELEPHONE EST (HK) CO., LTD
Manufacturer	pote ^k	Telephone Est Electronics Factory (Zhong Shan)
Product Name	ANDO	15W Wireless Charging Pad
Test Model No.	\mathbb{P}^{5}	2IHQI2125
Reference Model No.	N	2IHQI2125B0L2
Trade Mark	Nok	N/A Anbotek Anbotek Anbotek Anbotek Anbotek
Rating(s)	Anbot	Input: 5V—2A, 9V—2A Output: 15W Max
Test Ofen devil(a)	AN	por An Antek Apporer Anbo ek tostek

Test Standard(s)	:	FCC Part 1.1310, 1.1307(b)
Test Method(s)	÷	KDB680106 D01 RF Exposure Wireless Charging Apps v03

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 1.1307 & KDB680106 D01 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test

repared Bv

Sept. 07, 2023 Sept. 07, 2023 to Sept. 14, 2023

Stella Zhu

(Stella Zhu)

Idward pan

(Edward Pan)

Shenzhen Anbotek Compliance Laboratory Limited

Approved & Authorized Signer

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 4 of 11

Revision History

Report Version	Description	Issued Date		
R00	Original Issue.	Sept. 22, 2023		
nbotek Anbor An	otek Anboten And	nbotek Anbor At note		
k hotek Anbote. An	tek nbotek Anbo	hotek Anbote Ano		

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 5 of 11

1. General Information

1.1. Client Information

	200	
Applicant	:	TELEPHONE EST (HK) CO., LTD
Address	:	Room709, 7F, FuLi tianhe commercial building, Linhe, East Road and tianhe district, Guangzhou, China
Manufacturer	:	Telephone Est Electronics Factory (Zhong Shan)
Address	:	No.2 Heyuan Shengfeng Road, Xiaolan Town, Zhongshan, China
Factory	:	Telephone Est Electronics Factory (Zhong Shan)
Address	:	No.2 Heyuan Shengfeng Road, Xiaolan Town, Zhongshan, China
	Address Manufacturer Address Factory	Address:Manufacturer:Address:Factory:

1.2. Description of Device (EUT)

Product Name	:	15W Wireless Charging Pad
Test Model No.	:	2IHQI2125
Reference Model No.	:	2IHQI2125B0L2 (Note: All samples are the same except the model number and color, so we prepare "2IHQI2125" for test only.)
Trade Mark	:	N/A Anbotek Anbotek Anbotek Anbotek Anbotek Anbotek
Test Power Supply	:	AC 120V, 60Hz for Adapter
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	N/A Anboret Anboret Anboret Anboret Anboret
RF Specification		
Operation Frequency	:	110.1-205kHz
Antenna Type	:	Inductive loop coil Antenna
Antenna Gain(Peak)	:	0 dBi (Provided by customer)

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b



Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 6 of 11

1.3. Auxiliary Equipment Used During Test

Title	Manufacturer	Model No.	Serial No.
Xiaomi 67W adapter(CE)	Xiaomi	MDY-13-ES	WA622091100375G
Apple Phone	Apple	iPhone 12	DNPDJC7T0DYF

1.4. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
Antore	Electric and Magnetic field Analvzer	NARDA	EHP-200A	180ZX10202	Oct. 17, 2022	1 Year

1.5. Measurement Uncertainty

Magnetic Field Reading(A/m)	:	+/-0.04282(A/m)	P
Electric Field Reading(V/m)	:	+/-0.03679(V/m)	
- V			٦

The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

1.6. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. 518102

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301

FCC ID: 2ACE5-IH2125 Page 7 of 11

1.7. Disclaimer

- 1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 2. The test report is invalid if there is any evidence and/or falsification.
- 3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- 4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
- 5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- 6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACI

C ID: 2ACE5-IH2125 Page 8 of 11

2. Measurement and Result

2.1. Requirements

According to the item 5.b) of KDB 680106 D01v03:

Inductive wireless power transfer applications that meet all of the following requirements are excluded from submitting an RF exposure evaluation.

- 1) Power transfer frequency is less that 1 MHz
- 2) Output power from each primary coil is less than or equal to 15 watts.
- 3) The transfer system includes only single primary and secondary coils. This includes charging systems that may have multiple primary coils and clients that are able to detect and allow coupling only between individual pairs of coils
- 4) Client device is inserted in or placed directly in contact with the transmitter
- 5) Mobile exposure conditions only (portable exposure conditions are not covered by this exclusion)
- 6) The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit.

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
	(A) Limits for Occ	cupational/Controlled Ex	posures	
0.3-3.0	614	1.63	*(100)	6
3.0-30	1842/f	4.89/f	*(900/f ²)	6
30-300	61.4	0.163	1.0	6
300-1500	1	1	f/300	6
1500-100,000	1	1	5	6
	(B) Limits for Genera	l Population/Uncontrolle	ed Exposure	
03134	614	1.63	*(100)	30

Limits For Maximum Permissible Exposure (MPE)

1000 100,000	1	1	0	>					
(B) Limits for General Population/Uncontrolled Exposure									
0.3-1.34	614	1.63	*(100)	30					
1.34-30	824/f	2.19/f	*(180/f ²)	30					
30-300	27.5	0.073	0.2	30					
300-1500	/	1	f/1500	30					
1500-100,000	1	1	1.0	30					
	0.3-1.34 1.34-30 30-300 300-1500	(B) Limits for General 0.3-1.34 614 1.34-30 824/f 30-300 27.5 300-1500 /	(B) Limits for General Population/Uncontrolle 0.3-1.34 614 1.63 1.34-30 824/f 2.19/f 30-300 27.5 0.073 300-1500 / /	(B) Limits for General Population/Uncontrolled Exposure 0.3-1.34 614 1.63 *(100) 1.34-30 824/f 2.19/f *(180/f ²) 30-300 27.5 0.073 0.2 300-1500 / / / f/1500					

F=frequency in MHz

*=Plane-wave equivalent power density

RF exposure compliance will need to be determined with respect to 1.1307(c) and (d) of the FCC rules. The emissions should be within the limits at 300kHz in Table 1 of 1.1310(use the 300kHz limits for 150kHz:614V/m,1.63A/m).

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com Code:AB-RF-05-b Hotline 400-003-0500

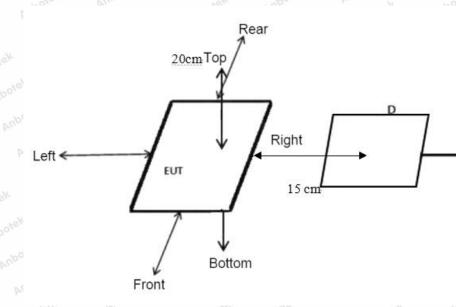
www.anbotek.com.cn





 Report No.: 18220WC30191301
 FCC ID: 2ACE5-IH2125
 Page 9 of 11

2.2. Test Setup



Note: Measurements should be made at 15 cm surrounding the EUT and 20cm above the top surface of the EUT.

2.3. Test Procedure

- 1) The RF exposure test was performed in anechoic chamber.
- 2) The measurement probe was placed at required test distance which is between the edge of the charger and the geometric center of probe.
- 3) The highest emission level was recorded and compared with limit as soon as measurement of each points

(A, B, C, D, E) were completed.(A is the right, B is the back, C is the left, D is the front, and E is the top.)

4) The EUT was measured according to the dictates of KDB 680106 D01 v03.

Remark; The EUT's test position A, B, C, D and E is valid for the E and H field measurements.

2.4. Test Result

- 2.4.1. Equipment Approval Considerations item 5.b of KDB 680106 D01 v03.
- 1) Power transfer frequency is less that 1 MHz
- The device operate in the frequency range 110.1-205kHz.
- 2) Output power from each primary coil is less than 15 watts The maximum output power of the primary coil is 15W.
- 3) The transfer system includes only single primary and secondary coils. This includes charging systems that may have multiple primary coils and clients that are able to detect and allow coupling

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b



FCC ID: 2ACE5-IH2125 Page 10 of 11

only between individual pairs of coils

Report No.: 18220WC30191301

- The transfer system including a charging system with only single primary coils is to detect and allow only between individual pairs of coils.

- 4) Client device is inserted in or placed directly in contact with the transmitter
- Client device is placed directly in contact with the transmitter.
- 5) Mobile exposure conditions only (portable exposure conditions are not covered by this exclusion)The EUT is a Mobile exposure conditions
- 6) The aggregate H-field strengths at 15 cm surrounding the device and 20 cm above the top surface from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit.
 Conducted the measurement with the required distance and the test results please refer to the section 2.4.

2.4.2. Environmental evaluation and exposi	ure limit according to FCC CFR 47 part 1, 1.1307(b), 1.1310
--	---

Temperature:	22.5°C	Relative Humidity:	49 %
Pressure:	1012 hPa	Test Voltage:	AC 120V, 60Hz for adapter

E-Field Strength at 15 cm surrounding the EUT and 20cm above the top surface of the EUT

Battery power	Frequency Range (kHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Reference Limit (V/m)	Limits Test (V/m)
1%	110.1-205	0.409	0.499	0.449	0.459	0.579	307	614
50%	110.1-205	1.443	1.883	1.373	1.503	1.673	307	614
99%	110.1-205	2.381	2.781	2.391	2.341	2.801	307	614
Stand-by	110.1-205	0.445	0.595	0.435	0.425	0.565	307	614

H-Field Strength at 15 cm surrounding the EUT and 20cm above the top surface of the EUT

Battery power	Frequency Range (kHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Reference Limit (A/m)	Limits Test (A/m)
1%	110.1-205	0.036	0.058	0.064	0.048	0.058	0.815	1.63
50%	110.1-205	0.390	0.480	0.380	0.380	0.550	0.815	1.63
99%	110.1-205	0.479	0.659	0.549	0.369	0.359	0.815	1.63
Stand-by	110.1-205	0.527	0.347	0.447	0.567	0.427	0.815	1.63

Note: All the situation(full load, half load and empty load) has been tested,only the worst situation (full load 15W) was recorded in the report.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30191301 FCC ID: 2ACE5-IH2125 Page 11 of 11

APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_MPE

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

----- End of Report -----

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b

